EFS-Web Receipt date: 11/16/2004

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Atty. Docket No. 20455-20338.00

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of: Robert DWILINSKI et al.

Serial No.: Not yet assigned

Filing Date: Concurrently herewith

For: PHOSPHOR SINGLE CRYSTAL SUBSTRATE AND METHOD FOR PREPARING THE SAME, AND

NITRIDE SEMICONDUCTOR DEVICE

**USING THE SAME** 

Examiner: Not Yet Assigned

Group Art Unit: N/A

## INFORMATION DISCLOSURE **STATEMENT UNDER 37 C.F.R. § 1.97 & 1.98**

MS Amendment Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. §1.97 and § 1.98, Applicants submit for consideration in the above-identified application the documents listed on the attached Form PTO/SB/08a/b. Copies of foreign documents and non-patent literature are submitted herewith. The Examiner is requested to make these documents of record.

va-84765

Application No.: Not yet as a new



The documents listed on the attached Form PTO/SB/08a/b were cited in an International Search Report mailed February 18, 2003, issued in PCT/IB02/04441; an International Search Report mailed February 18, 2003, issued in PCT/JP02/11136; an International Search Report mailed February 19, 2003, issued in PCT/IB02/04185; an International Search Report mailed April 8, 2003, issued in PCT/JP02/12969; an International Search Report mailed April 8, 2003, issued in PCT/JP02/13079; an International Search Report mailed April 8, 2003, issued in PCT/JP02/12956; an International Search Report mailed April 16, 2003, issued in PCT/PL02/00077; a Preliminary Notice of Rejection of the IPO dated February 2, 2004, issued in Taiwan Patent Application No. 091110622; a Preliminary Examination Report mailed February 10, 2004, issued in PCT/JP02/11136; a Preliminary Notice of Rejection of the IPO dated August 30, 2004, issued in Taiwan Patent Application No. 091125039; a Notice of References Cited issued in U.S. Application No. 10/147,319; and a Notice of References Cited issued in U.S. Application No. 10/147,319; and a Notice of References Cited issued in U.S. Application No. 10/147,318 (copy attached).

This Information Disclosure Statement is submitted:

With the application; accordingly, no fee or separate requirements are required.

Applicants would appreciate the Examiner initialing and returning the Form PTO/SB/08a/b, indicating that the information has been considered and made of record herein.

The information contained in this Information Disclosure Statement under 37 C.F.R. § 1.97 and § 1.98 is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist; (iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

EFS-Web Receipt date: 11/16/2004

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Application No.: Not yet assigned

In the unlikely event that the transmittal form is separated from this document and the Patent Office determines that an extension and/or other relief (such as payment of a fee under 37 C.F.R. § 1.17 (p)) is required, Applicants petitions for any required relief including extensions of time and authorize the Commissioner to charge the cost of such petitions and/or other fees due in connection with the filing of this document to **Deposit Account No. 03-1952** referencing

Dated: November 16, 2004

<u>204552033800</u>.

Respectfully submitted,

Barry E. Bretschneider

Registration No.: 28,055

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McLean, Virginia 22102 (703) 760-7743





ALTERNATIVE TO PTO/SB/08a/b (06-03)

		66 1440/DTO		Complete if Known		
Subs	stitute for form 1449/P	U		Application Number Not yet assigned \( \bigcap \)		
IN	INFORMATION DISCLOSURE			Filing Date	Concurrently herewith	
	FORMATION DISCLOSURE ATEMENT BY APPLICANT  (Use as many sheets as necessary)  1 of 2		First Named Inventor	Robert DWILINSKI		
	MILMEN	ATION DISCLOSURE IENT BY APPLICANT as many sheets as necessary)	Art Unit	N/A		
	(Use as many sheets as necessary)			Examiner Name	Not Yet Assigned	
Sheet	1	of	2	Attorney Docket Number	204552033800	

			U.S. PA	TENT DOCUMENTS	
Examiner Initials*	No.1	Document Number  Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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<del>                                     </del>	/1 <u>2</u> 9.L.	JP-11-307813	11-05-1999		English abstract	X

\*EXAMINER: Initial if information considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). See Kinds Codes of USPTO Patent Documents at <a href="https://www.uspto.gov">www.uspto.gov</a> or MPEP 901.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language Translation is attached.

Examiner | /Michael Logie/ | Date | 05/29/2008 | Signature | REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.L./





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INFORMATION DISCLOSURE				Filing Date	Concurrently herewith	-8
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	(Use as many sheets as necessary)			Art Unit	N/A	
				Examiner Name	Not Yet Assigned	
Sheet	2	of	2	Attorney Docket Number	204552033800	

		NON PATENT LITERATURE DOCUMENTS				
Examiner nitials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
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<sup>\*</sup>EXAMINER: Initial if information considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>&</sup>lt;sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.